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Automated rejection and repair of bad trials in MEG/EEG

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Abstract—We present an automated solution for detecting bad trials in magneto/electroencephalography (M/EEG). Bad trials are commonly identified using peak-to-peak rejection thresholds that are set manually. This work proposes a solution to determine them automatically using cross-validation. We show that automatically selected rejection thresholds perform at par with manual thresholds, which can save hours of visual data inspection. We then use this automated approach to learn a sensor-specific rejection threshold. Finally, we use this approach to remove trials with finer precision and/or partially repair them using interpolation. We illustrate the performance on three public datasets. The method clearly performs better than a competitive benchmark on a 19-subject Faces dataset.

Keywords— magnetoencephalography, electroencephalography, preprocessing, artifact rejection, automation, machine learning

I. INTRODUCTION

Magneto-/electroencephalography (M/EEG) measure brain activity by recording magnetic/electrical signals in multiple sensors. M/EEG data is inherently noisy, which makes it necessary to combine (e.g., by averaging) multiple data segments (or trials). Unfortunately, trials can sometimes be contaminated due to high amplitude artifacts which can reduce the effectiveness of such strategies. Added to this, some sensors can also be bad and repairing or removing them is critical for algorithms downstream in the pipeline. In this paper, we aim to offer an automated solution to this problem of detecting and repairing bad trials/sensors.

Existing software for processing M/EEG data offer a rudimentary solution by marking a trial as bad if the peak-to-peak amplitude in any sensor exceeds a certain threshold [1]. The threshold is usually set manually after visual inspection of the data. This can turn tedious for studies involving hundreds of recordings (see the Human Connectome Project [2] as an example of such a large-scale study).

Modern algorithms for rejecting trials compute more advanced trial statistics. FASTER [3], for example, rejects based on a threshold on the z-score of the trial variance, its amplitude range, etc. Riemannian potato filtering [4] works on covariance matrices and Artifact Subspace Reconstruction [5] rejects based on the variance of artifact components. However, these methods are not fully satisfactory as rejection thresholds must be fixed or manually tuned. Another promising approach is to apply algorithms robust to outliers. For instance, robust regression [6] can compute an average by downweighting outliers. For single-trial analysis, an outlier detection algorithm is better suited. The Random Sample Consensus (RANSAC) algorithm implemented as part of the PREP pipeline [7], for example, annotates outlier sensors as bad.

In this paper, we make the following contributions. First, we offer a data-driven cross-validation framework (Figure 1) to automatically set the rejection threshold. Secondly, we show that the rejection threshold is sensor-specific and varies considerably across sensors. Finally, we show that taking into account this variation in sensor-specific thresholds can in fact lead to improved detection and repair of bad trials. Our approach unifies rejection of bad trials and repair of bad sensors in a single method.

II. METHODOLOGY

Let us denote the data by $X \in \mathbb{R}^{N \times P}$ where $N$ is the number of trials and $P$ is the number of features. $P$ could be $Q T i.e.$, the number of sensors $Q$ times the number of time points $T$ if a global threshold has to be computed, or it could be $T$ if only one sensor is considered. To simplify notation, we denote a trial by $X_i = (X_{i1}, X_{i2}, \ldots, X_{iP})$. Also, we define the mean of the trials as $\overline{X} = \frac{1}{N} \sum_{i=1}^{N} X_i$, the median of the

![Fig. 1: Mean cross-validation error as a function of peak-to-peak rejection threshold. The root mean squared error (RMSE) between the mean of the training set (after removing the trials marked as bad) and the median of the validation set was used as the cross-validation metric. The optimal data-driven threshold (auto reject, global) with minimum RMSE closely matches the human threshold.](image-url)
trials as $X$, and the peak-to-peak amplitude of the trials as $\text{ptp}(X_i) = \max(X_i) - \min(X_i)$.

\textbf{A. Global threshold}

If we are estimating an optimal global threshold, then $P = QT$ such that the sensor time-series are concatenated across the second dimension of the data matrix. For a fold $k$ (out of total $K$ folds), the data is split into a training set $X_{\text{train}_k}$ and a validation set $X_{\text{val}_k}$ such that $\text{val}_k = [1..N] \setminus \text{train}_k$ (see [8] for another use of cross-validation for parameter estimation in the context of M/EEG). The peak-to-peak amplitudes for all trials $X_i$ in the training set is computed as:

$$A = \{ \text{ptp}(X_i) \mid i \in \text{train}_k \} \quad (1)$$

Now, let’s say we have $L$ candidate global thresholds, $\tau_l \in \mathbb{R}$ for $1 \leq l \leq L$. Then, for one candidate threshold $\tau_l$, the set of indices of the good trials $G_l$ are computed as:

$$G_l = \{ i \in \text{train}_k \mid \text{ptp}(X_i) < \tau_l \} \quad (2)$$

The error metric for one fold of the cross-validation for a particular threshold is the Root Mean Squared Error (RMSE) computed as:

$$e_{kl} = \| \overline{X}_{G_l} - \overline{X}_{\text{val}_k} \|_{\text{Fro}} \quad (3)$$

where $\| \cdot \|_{\text{Fro}}$ is the Frobenius norm. The RMSE is computed between the mean of the good trials in the training set $G_l$ with the median of the trials in the validation set. A low rejection threshold will remove too many trials (leading to high RMSE) whereas a high rejection threshold does not remove the bad trials. Cross validation will find an optimal value which is somewhere in between. The median of the trials in the validation set is used to avoid noisy metric values due to outlier trials. This is inspired from literature on robust cross-validation methods [9], [10] where the loss function is made robust to outlier data.

The threshold with minimum mean error is selected as the global threshold, i.e.,

$$\tau_* = \tau_{l_*} \text{ with } l_* = \arg \min_l \frac{1}{K} \sum_{k=1}^{K} e_{kl} \quad (4)$$

We call this method auto reject (global). Note that the threshold learnt this way matches values set manually (Figure 1) and is indeed very different across subjects (Figure 2A).

\textbf{B. Sensor-specific thresholds}

In practice however, a global rejection threshold for all sensors is certainly not optimal. Depending on the sensor noise levels and the experiment, each sensor can necessitate a different rejection threshold (Figure 2B). Learning a sensor-specific threshold is what we propose next. With a sensor-specific threshold, each sensor votes whether a trial should be marked as good or bad. If a trial is voted as bad by a minimum number of sensors, then it will be marked as bad.

The cross-validation procedure here is the same as in Section II-A except that now $P = T$. For every sensor, one can thus learn a sensor-specific threshold $\tau^{q}_l$ where $q \in [1..Q]$.

\textbf{C. Trial-by-trial interpolation}

Once we find the bad trials by consensus, the next step is to repair the trials which are good but have a limited number of bad sensors. Since these sensors might be bad locally (i.e., bad for only a few trials) or globally (i.e., bad for all trials), we choose to interpolate the sensors trial-by-trial. Note that we cannot interpolate more than a certain number of sensors. This number depends on the data and the total number of sensors present. Therefore, we choose to interpolate only the worst $\rho$ sensors.
For each trial where the number of bad sensors is larger than \( \rho \), the bad sensors are ranked based on the peak-to-peak amplitude. The higher the peak-to-peak amplitude, the worse is the sensor. That is, we can assign a score \( s_{ij} \) which is \( \sim \infty \) if the sensor is good and equal to the peak-to-peak amplitude if the sensor is bad:

\[
s_{ij} = \begin{cases} 
\infty & \text{if } C_{ij} = 0 \\
\text{ptp}(X_{ij}) & \text{if } C_{ij} = 1
\end{cases}
\]  

(7)

This leads us to the following rule for interpolating a sensor \( X_{ij} \):

\[
X_{ij} = \begin{cases} 
\text{interp}(X_{ij}), & \text{if } (0 < \sum_{j' = 1}^{\rho} C_{ij'} \leq \rho) \\
\text{interp}(X_{ij}), & \text{if } (\rho < \sum_{j' = 1}^{\rho} C_{ij'} \leq \kappa) \\
X_{ij}, & \text{if } (s_{ij} > s_{i(N-\rho)})
\end{cases}
\]  

(8)

where the notation \( s_{i(k)} \) indicates the \( k \)-th order statistic, i.e., the \( k \)-th smallest value. \text{interp}(\cdot) is a generic function which interpolates the data. That is, when the number of bad sensors in a trial \( \sum_{j = 1}^{\rho} C_{ij} \) is less than the maximum number of sensors \( \rho \) which can be interpolated, they are all repaired by interpolation. However, when this is not the case, only the worst \( \rho \) sensors are repaired.

The optimal values of parameters \( \kappa \) and \( \rho \) are estimated using grid search for the same error metric as defined in Equation 3. We call this method \textit{auto reject (local)}.

III. RESULTS

A. Datasets

We evaluated our algorithms on three publicly available datasets. The first is the MNE sample dataset [13] containing 204 gradiometer sensors (1 globally bad) and 102 magnetometer sensors. The second is the EEGBCI motor dataset [14] with 104 subjects and the final one is the Faces dataset [15] with 19 subjects. The bad channel annotations for each run and subject was available from the authors of the Faces dataset [15].

For the EEGBCI and MNE sample dataset, the trials are 700 ms long with a baseline period of 200 ms with respect to the trigger (auditory left tone for MNE sample and resting for EEGBCI). In the Faces dataset, we use the trials where famous faces were shown. The data was bandpass filtered between 1 and 40 Hz. The trials were 1 s long with a baseline period of 200 ms.

B. Auto reject (global)

Figure 1 shows, on the sample dataset, how the global threshold can be selected by cross-validation. One can observe how a low rejection threshold leads to high RMSE due to removal of too many trials whereas high rejection threshold leads to high RMSE because the bad trials are not removed. The reader may note that the automatic threshold is very close to a carefully chosen manual threshold. Figure 2A shows the results computed for 104 subjects in the EEGBCI dataset. Note that the threshold does indeed vary across subjects.

C. Auto reject (local)

This auto reject (local) approach finds the thresholds at the level of each sensor. The candidate thresholds used vary between 2–400 \( \mu V \) for EEG; 400–20000 \( \text{ft/cm} \) for gradiometers; and 400–20000 \( \text{ft} \) for magnetometers.

Figure 2B demonstrates that the sensor-level thresholds for rejection are indeed different across sensors. This is the motivation for the more fine-grained technique based on consensus. Figure 3 demonstrates that the algorithm indeed improves the data quality. The bad MEG sensor which showed high

![Original data](Fig. 3: The evoked response (average of data across trials) on the sample dataset (Section III) for gradiometer sensors before and after applying the \textit{auto reject} algorithm. Each sensor is a curve on the plots. Manually annotated bad sensor is shown in red. The algorithm finds the bad sensor automatically and repairs it for the relevant trials.)

![After auto reject](Fig. 4: RMSE with no rejection applied, \textit{auto reject (global)}, and RANSAC. Each point represents a subject from the Faces dataset [15]. \textit{Auto reject} has a better RMSE whenever a point lies above the dotted red line. Note that \textit{auto reject} almost always performs as well as or better than the other methods.)
IV. Discussion

The algorithm described here is fully automated requiring no manual intervention. This is particularly useful for large-scale experiments. It also implies that the analysis pipeline is free from experimenter’s bias while rejecting trials.

A big strength of the auto reject algorithm is that the average evoked response obtained can be used in noise-normalized source modeling techniques such as dSPM or sLORETA without any modifications. Indeed, such methods are not readily applicable if the average is a weighted mean (as in robust regression [6]), which changes how the variance of the noise should be calculated. However this is not the case in our method.

Compared to other methods (e.g., PREP [7]), we do not make the assumption that sensors must be globally bad. In fact, it can detect and repair sensors even when they are locally bad, thus saving data. Of course, with suitable modifications, the method can also be used to detect flat sensors. Note that, even though we used peak-to-peak threshold as our statistic (as in robust regression [6]), which changes how the variance of the noise should be calculated. However this is not the case in our method.

To avoid the dangers of double dipping, our advice is to run the algorithm on each condition separately and not on the contrast. Instead of using spline interpolation or Minimum Norm Estimates to clean the sensor data in Section II-B, one could also use the SNS algorithm [16] or the algorithm based on Signal Space Separation [17]. Our algorithm is complementary to these efforts and can only benefit from improvements in these techniques. Comparing these interpolation methods and their effect on our algorithm will be done in future work. Finally, when spatial filtering methods [18], [19] are used for artifact removal, they should be applied after our algorithm.

V. Conclusion

We have presented an algorithm to automatically reject and repair bad trials/sensors based on their peak-to-peak amplitude which is so far done manually in standard preprocessing pipelines. The algorithm was tested on three publicly available datasets and compared to a competitive benchmark. Finally, the code will be made publicly available.

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